Supporting Information

Growth of BiVO₄ Nanoparticles on WO₃ Porous Scaffold: Improved Water-Splitting by High Band-Edge Light Harvesting

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Electrode	J _{H2O} at 1.23V _{RHE}	IPCE (%) at 500nm	Reference
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WO ₃ /BiVO ₄ IO	1.3*	5	1
WO ₃ /BiVO ₄ porous structure	4.7*	3	2
WO ₃ /W:BiVO ₄ /BiVO ₄	2.6	-	3
WO ₃ /BiVO ₄ IO	5.1*	5	4
WO ₃ /W:BiVO ₄ NWs	3.1	6	5
WO ₃ /(W,Mo)-BiVO ₄ Nanohelix	5.3*	8	6
WO ₃ /BiVO ₄ NRs	3.25*	5	7
WO ₃ /M:BiVO ₄ film	1.7	5	8
WO ₃ /SnO ₂ /BiVO ₄ film	2.5	3	9
SnO ₂ /WO ₃ /BiVO ₄ film	1.8	2	10
WO ₃ /BiVO ₄ film	1.5	7.5	11
BiVO4/WO3 NRs	1.2	2	12

Table S1. Water oxidation photocurrent density and onset potential of various $WO_3/BiVO_4$ photoanodes.

* The value in parentheses is the water splitting current of the electrode coated with the oxygen evolution catalyst.



Figure S1. (a) Mott-Schottky plots of WO₃ and BiVO₄ films. (b) Mott-Schottky plots of BiVO₄ before and after Mo doping. Mott-Schottky measurements were conducted using impedance spectroscopy in a dark environment in 0.5 M Na₂SO₄ solution at a frequency of 1 kHz. We compared the carrier densities before and after doping, 2.33 x 10^{21} cm⁻³ for Mo-doped BiVO₄ and 7.33 x 10^{19} cm⁻³ for pristine BiVO₄



Figure S2. SEM images of WO₃ porous structure with polymer nanosphere-infiltrated BiVO₄ precursor after annealing with different temperature (a) 70 °C, (b) 340 °C and (c) 450 °C.



Figure S3. Particle radius distribution of $BiVO_4$ NP coated on the WO₃ structure. The distribution was obtained from measuring diameters of 200 particles.



Figure S4. SEM images of BiVO₄ nanoparticles prepared by various precursor concentrations (a-c) and thicknesses (d-f).



Figure S5. Current-potential (J–V) curves of $BiVO_4$ NP/WO₃ photoanodes a) with various precursor concentrations of $BiVO_4$ and b) with various photoanode thicknesses. The coating thickness of $BiVO_4$ layer was not optimized.



Figure S6. XRD pattern of the Mo:BiVO₄ NP/WO₃. The typical (121) and (040) planes of scheelite-monoclinic BiVO₄ were observed, and the (002), (020), (200) and (220) planes of monoclinic WO₃ were also observed.



Figure S7. BiVO₄ NP/WO₃ TEM images with various magnifications.



Figure S8. (a) SEM image and (b) high magnification SEM image of $BiVO_4$ shell / WO_3 photoanode. The scale bars are (a) 1 μ m and (b) 200 μ m.



Figure S9. a) Diffuse-reflectance spectra, b) diffuse-transmittance spectra and c) Tauc plots using the Kubelka-Munk function of the BiVO₄ NP/WO₃ and BiVO₄ shell/WO₃ structures. The optical bandgap energy was measured using the Tauc relation, $(ahv)^n = A(hv - E_g)$, where *a* denotes the absorption coefficient, *hv* is the photon energy, A is a constant, E_g is the bandgap, and the exponent *n* depends on the type of transition (*n* = 2 for direct bandgap). The Kubelka-Munk function, F(R), was employed to obtain the absorption coefficient, *a*; the Kubelka-Munk equation is $a = (1-R)^2/2R$, where R corresponds to the diffuse reflectance.



Figure S10. Details of the calculation of the separation efficiency is following.

a) Global tilt spectra irradiance, E.

b) Photon flux, N_p, calculated by the irradiance/energy of a photon: $E/(hc/\lambda) = E \times \lambda \times (5.04 \times 10^{15})$, where h is Plank's constant (4.13 × 10⁻¹⁵ eV s⁻¹), c is the velocity of light (3 × 10⁸ m s⁻¹), and λ is the wavelength.

c) LHE of BiVO₄/WO₃ photoanodes

d) Charge density of BiVO₄/WO₃ photoanodes calculated by N_p × e × LHE, where e is the elementary charge (1.6022 × 10⁻¹⁹ C), and $J_{\text{max}} \times \eta_{\text{abs}}$ represents the integration of the charge density.

The product of $J_{\text{max}} \times \eta_{\text{abs}}$ was obtained from the integration of the charge density, which is N_p \times e \times LHE, where N_p is the photon flux of the AM 1.5G spectrum, and e is the elementary charge (1.6022 \times 10⁻¹⁹ C).



Figure S11. Nyquist plot of BiVO₄ NP/WO₃ and BiVO₄ shell/WO₃. This experiment was also analyzed under 1 sun illumination and at 0.6 V_{RHE}. We compared the charge transfer resistance (R_{ct}) through an equivalent circuit. The resistances of BiVO₄ NP / WO₃ and BiVO₄ shell / WO₃ are 1297 Ω and 1951 Ω , respectively.



Figure S12. TEM elemental mapping of Fe and Ni for the FeOOH/NiOOH/BiVO₄ NP/WO₃.



Figure S13. Photocurrent-voltage curves of BiVO₄ NP/WO₃ and FeOOH/NiOOH/BiVO₄ NP/WO₃ photoanodes without illumination.



Figure S14. Independent runs of the FeOOH/NiOOH/BiVO₄ NP/WO₃ photoanode at 1.23 V_{RHE} under AM 1.5G illumination.

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